PATENT

Attorney's Docket No. 53470P020D

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

in Re	Patent Application of:)	Examiner:
	Stephen W. Smith, et al.	Art Unit:
Applic	ation No.:	,
Filed:	Herewith)	
For:	INTEGRATED MICROMACHINE RELAY FOR AUTOMATED TEST EQUIPMENT APPLICATIONS	

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

Enclosed is a copy of Information Disclosure Citation Form PTO-1449 together with copies of the documents cited on that form. It is respectfully requested that the cited documents be considered and that the enclosed copy of Information Disclosure Citation Form PTO-1449 be initialed by the Examiner to indicate such consideration and a copy thereof returned to applicant(s).

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Pursuant to 37 C.F.R. § 1.97, the submission of this Information Disclosure Statement is not to be construed as a representation that a search has been made and is not to be construed as an admission that the information cited in this statement is material to patentability.

Pursuant to 37 C.F.R. § 1.97, this Information Disclosure Statement is being submitted under one of the following (as indicated by an "X" to the left of the appropriate paragraph):

XXX	37 C.F.R. §1.97(b).
	37 C.F.R. §1.97(c). If so, then enclosed with this Information Disclosure Statement is <u>one</u> of the following:
	A statement pursuant to 37 C.F.R. §1.97(e) or
	A check for \$180.00 for the fee under 37 C.F.R. § 1.17(p).
	37 C.F.R. §1.97(d). If so, then enclosed with this Information Disclosure Statement are the following:
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(2) A check for \$180.00 for the fee under 37 C.F.R. §1.17(p) for submission of the Information Disclosure Statement.

If there are any additional charges, please charge Deposit Account No. 02-2666.

Respectfully submitted,

BLAKELY, SOKOLOFF, TAYLOR & ZAFMAN LLP

Dated: September 16, 2003

Lester J. Vincent Reg. No. 31,460

12400 Wilshire Blvd. Seventh Floor Los Angeles, CA 90025 (408) 720-8300

Substitute	for Form 1449	9/PTO			Complete if	Known
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Examiner Initials*	Cite No.1		Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant
		Num	ber-Kind Code ² (If known)			Figures Appear
		US-	3,609,991	10/5/1971	Chu et al.	
		US-	3,714,572	1/30/1973	Ham et al.	
	<u> </u>	US-	3,882,691	5/13/1975	Baines et al.	
		US-	3,946,276	3/23/1976	Braun et al.	
	<u> </u>	US-	4,044,396	8/23/1977	Haws et al.	
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		US-	4,809,134	2/25/1989	Tustaniwskyj et al.	
		US-	4,860,164	8/22/1989	Kaufman	

Cite No. ¹	Foreign Patent Document Country Code ³ Number ⁴ Kind Code ⁵	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Le
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Examiner Initials*	Cite No.		Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant
		Numt	per-Kind Code ² (If known)			Figures Appear
		US-	4,865,123	9/12/1989	Kawashima et al.	
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		US-	5,933,019	8/3/1999	Depue	
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		US-	6,208,510 B1	3/27/2001	Trudeau et al.	
		US-	6,449,741 B1	9/10/2002	Organ et al.	
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		FO	REIGN PATEN	T DOCUMENTS		
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ Number ⁴ Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T°

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		Chun-Hung Chen and Jacob A. Abraham, "High Quality Tests For Switch-Level Circuits Using Current and Logic Test Generation Algorithms," IEEE, 1991 International Test Conference, pp. 615-622 (1991)					1	
						vith Current Monitoring," IEEE,	1991 International Test)
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary) She t 3 of 5 Attorney Docket Number Stephen W. Smith Art Unit Examiner Name She t Cite No¹ Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published Wojciech Maly, "Current Testing," IEEE, 1990 International Test Conference, p. 257 (1990) S. Wayne Bolinger and Scott F. Midkiffs, "On Test Generation for IDDQ Testing of Bridging Faults in CMOS Circuits," IEEE, 1991 International Test Conference, pp. 598-607 (1991) E. Vandris and G. Sobelman, "A Mixed Functional/Iddq Testing Methodology for CMOS Transistor Faults," IEEE, 1991 International Test Conference, pp. 608-614 (1991) Chun-Hung Chen and Jacob A. Abraham, "High Quality Tests For Switch-Level Circuits Using Current and Logic Test Generation Algorithms," IEEE, 1991 International Test								
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Examiner Initials*	Cite No ¹	iteı	m (book, n	the author (in CAPI nagazine, journal, s number(s), pub	TAL LETTERS), title of the article erial, symposium, catalog, etc.), dolisher, city and/or country where p	ate, page(s), volume-issue published	T ²			
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		LTX V	alidMaste	r Plus Brochure (Prior to May 16, 2001) (USA)					

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				NON	PATENT	LIT	ERATURE DOCUMENTS				
Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published								T ²	
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